

Search Notes

Application/Control No.

09/989,765

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

BARTZ ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	501.1	9/22/2005	MK
	764,781	9/22/2005	MK
	503	9/23/2005	MK
716	1	9/22/2005	MK
Updated	Search	3/27/2006	MK
Updated	Search	9/20/2006	MK
Updated	Search	3/26/2007	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	9/22/2005	MK
West Search	9/22/2005	MK
West Search	9/23/2005	MK
West Updated	3/27/2006	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	9/20/2006	MK
NPL (IEEE)	9/20/2006	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	3/26/2007	MK